DECENTRALIZED APPROACH FOR FAULT DIAGNOSIS OF DISCRETE EVENT SYSTEMS

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Abstract: This paper proposes a decentralized approach to realize the diagnosis of Discrete Event Systems (DES). This approach is based on a set of local diagnosers, each one of them diagnoses faults entailing the violation of the local desired behavior. These local diagnosers infer the fault's occurrence using event sequences, time delays between correlated events and state conditions, characterized by sensors readings and commands issued by the controller. An adapted codiagnosability notion is formally defined in order to ensure that the set of local diagnosers is able to diagnose all faults entailing the violation of the global desired behavior. An example is used to illustrate the proposed approach.

1 INTRODUCTION

Manufacturing systems are too large to perform a centralized diagnosis. Moreover, they are informationally and geographically decentralized. Thus a diagnosis module with a decentralized structure is the most adapted one for this kind of systems. However, the challenge of decentralized diagnosis methods is to perform local diagnosis equivalent to the centralized one. Indeed, the partial observation of the system may lead to an ambiguity of the final diagnosis methods can be found in (Debouk, 2000), (Pandalai, 2000), (Qiu, 2005), and the references therein.

Failure diagnosis in DES requires that once a failure is occurred, it must be detected and isolated within a bounded delay or number of events. This property is verified using a notion of diagnosability. This notion can be formalized differently according to whether the fault is modelled as the execution of certain faulty events, event-based notion, or as the consequence of reaching at certain faulty states, state-based notion. In (Sampath, 1994), an event-based diagnosability notion is defined. The system model is based on a finite-state automaton. This notion defines a diagnoser that uses the history of events to detect the occurrence of a failure. Consequently, a system is diagnosable if and only if

any pair of faulty/non-faulty behaviors can be distinguished by their projections to observable behaviors. The event-based diagnoser can diagnose actuator and sensor permanent and intermittent failures. However, the diagnoser and the system model must be initiated at the same time to allow the system model and diagnoser to response simultaneously to events. This initialization is hard to obtain in manufacturing systems since their initial state may not be known. To enhance the diagnosability, the above framework is extended to dense-time automata (Tripakis, 2002). This extension is useful since it permits to model plants with timed behavior.

In (Pandalai, 2000), an event-based approach is proposed to monitor manufacturing systems. In this approach, the timed sequence events, generated by the DES, is compared with a set of specifications of normal functioning called templates. These templates are based on the notion of expected event sequencing and timing relationships. They are suitable for modelling processes in which both single-instance and multiple-instance behaviors are exhibited concurrently. However, these templates do not allow the analysis of diagnosability properties, which are based on a diagnosability notion.

To find a remedy to the initialization problem, a state-based diagnosability notion is proposed in (Lin, 1994), (Zad, 2003). In this notion, since the system states describe the conditions of its components,

124 Sayed Mouchaweh M., Philippot A. and Carré-Ménétrier V. (2007). DECENTRALIZED APPROACH FOR FAULT DIAGNOSIS OF DISCRETE EVENT SYSTEMS. In Proceedings of the Fourth International Conference on Informatics in Control, Automation and Robotics, pages 124-129 DOI: 10.5220/0001627301240129 Copyright © SciTePress diagnosing a fault can be seen as the identification in which state or set of states the system belongs to. However, the diagnosis is limited to the case of actuator faults. While manufacturing systems use many sensors entailing the necessity of diagnosing also their faults.

This paper presents a decentralized diagnosis approach to perform the diagnosis of manufacturing systems. The paper is structured as follows. Firstly, the different steps of the proposed approach necessary to construct the local diagnosers are detailed. Secondly, a timed-event-based diagnosability notion is presented. Then, in order to verify the codiagnosability property of local diagnosers, this notion is extended to the codiagnosability notion. Finally, a simple example is used to illustrate the proposed approach.

2 DECENTRALIZED DIAGNOSIS APPROACH

2.1 System Boolean Models

We use Boolean DES (BDES) modelling, introduced in (Wang, 2000), to model the equipments (sensors and actuators) behavior of the system. The system model G consists of n local models: G_1, \ldots, G_n , each one owns its local observable events responsible of a restricted area of the process. $G^{i} = (\Sigma, Q, Y, \delta, h, q_{0})$ is represented as Moore automaton and L = L(G)denotes its corresponding prefixed closed language. Σ is a set of finite observable and unobservable events. Q is the set of states, Y is the output space, δ : $\Sigma^* \ge Q \to Q$ is the state transition function and Σ^* is the set of all event sequences of the language L(G). $\delta(\sigma, q)$ provides the set of possible next states if σ occurs at q. h: Q \rightarrow Y is the output function and h(q) is the observed output at q. q_0 is the initial state.

Let $\Sigma_{\Pi} = \{\Pi_{Fl}, \Pi_{F2}, ..., \Pi_{Fr}\}$ be the set of fault partitions. Each fault partition, $\Pi_{Fj}, j \in \{1, 2, ..., r\}$, corresponds to some kind of faults in an equipment element (sensor or actuator). We assume at most one fault may occur at a time. These faults must be considered when BDES models.

In (Balemi, 1993), Balemi *et al.* defined controllable events $\Sigma_c \subseteq \Sigma$ as controller's outputs sent to actuators, and uncontrollable events $\Sigma_u \subseteq \Sigma$ as the controller's inputs coming from sensors. ($\Sigma_o = \Sigma_c \cup \Sigma_u$) $\subset \Sigma$ is the set of observable events. The unobservable events are failure events or other events which cause changes not recorded by sensors.

Let G^i and its corresponding prefixed closed language, $L^i = L(G^i)$, be the local model of the restricted area of the system observed by this model. $G^i = (\Sigma^i, Q^i, Y^i, \delta^i, h^i, q_0^i)$ is represented as Moore automaton. $\Sigma_0^i = \Sigma_c^i \cup \Sigma_u^i$ is the set of local observable events by G^i and $\Sigma_0^i \subset \Sigma_0$. The other notations have the usual definition but for the restricted area observed by G^i .

G observes the system by one global projection function or mask, $P_L: \Sigma^* \cup \{\varepsilon\} \to \Sigma_0^*$, where Σ_0^* is the set of all observable event sequences observed by *G*. The inverse projection function is defined as: $P_L^{-1}(u) = \{s \in L: P_L(s) = u\}$. Similarly, a local projection function can be defined for each local model G^i as: $P^i: \Sigma^{i^*} \cup \{\varepsilon\} \to \Sigma_0^{i^*}$.

Each state q_j of G is represented by an output vector h_j considered as a Boolean vector whose components are Boolean variables. Let d denote the number of state variables of G, the output vector h_j of each state q_j can be defined as:

$$\forall q_j \in Q, h(q_j) = h_j = (h_{jl}, ..., h_{jp}, ..., h_{jd}), h_{jp} \in \{0, 1\},$$

 $1 \le j \le 2^d, h_j \in Y \subseteq IB^d$

A transition from one state to another is defined as a change of a state variable from 0 to 1, or from 1 to 0. Thus each transition produces an event α characterized by either rising, $\alpha = \uparrow h_{jp}$, or falling, $\alpha = \downarrow h_{ip}$, edges where $p \in \{1, 2, ..., d\}$.

To describe the effect of the occurrence of an event $\alpha \in \Sigma_0$, a displacement vector $E_\alpha = (e_{\alpha l}, ..., e_{\alpha p}, ..., e_{\alpha a l})$ is used. If $e_{\alpha p} = 1$, then the value of p^{th} state variable h_{jp} will be set or reset when α occurs. While if $e_{\alpha p} = 0$, the value of p^{th} state variable h_{jp} will remain unchanged:

$$\forall q_i, q_j \in Q, \forall \alpha \in \Sigma_o, q_j = \delta(\alpha, q_i) \Longrightarrow h_j = h_i \oplus E_\alpha \quad (1)$$

The set of all the displacement vectors of all the events provides the displacement matrix *E*. For each event $\alpha \in \Sigma_0$, an enablement condition, $en_\alpha(q_i) \in \{0, 1\}$, is defined in order to indicate if the event α can occur at the state q_i , $en_\alpha(q_i) = 1$, or not:

 $\forall q_i, q_i \in Q, \forall \alpha \in \Sigma_o, q_i = \delta(\alpha, q_i) \Longrightarrow h_i = h_i \oplus (E_\alpha, e_\alpha(q_i))$ (2)

2.2 Constrained-System Boolean Model

Let $S = (\Sigma, Q_S, Y, \delta_S, h, q_0)$ denote the constrainedsystem model, characterized as Moore automaton. It defines the global desired behavior of the system and it is represented by the prefixed closed specification language $K = L(S) \subseteq L(G)$. S can be obtained using different algorithms from the literature as the ones developed in (Philippot, 2005), (Ramadge, 1987) and the references therein. To obtain the transition function δ_S , the enablement conditions for all the system events at each state must satisfy all the specifications *K*, representing the desired behavior:

$$\forall \alpha \in \Sigma_0, \forall q_i, q_j \in Q_S, q_j = \delta_S(\alpha, q_i) \Rightarrow \\ en_\alpha(q_i) = 1, h_j = h_i \oplus (E_\alpha.en_\alpha(q_i))$$
(3)

Each local model G^i has a local constrained model S^i , which is a part of the global constrained model S. S^i is represented by the specification language $K^i = L(S^i)$, which is included in K. S^i is Moore automaton: $S^i = (\Sigma^i, Q^i_S, Y^i, \delta^i_S, h^i, q^i_0)$ and $Q^i_S \subset Q^i$. All these notations have the usual definition but for the local constrained-system model S^i .

2.3 Codiagnosability Notion

2.3.1 Basic Definitions

Let Ψ_{Fj} define the set of all the event sequences ending by a fault belonging to the fault partition Π_{Fj} . Thus $\Psi_F = \bigcup_{j=1}^r (\Psi_{F_j})$ denotes the set of all the event sequences ending by a fault belonging to one of fault partitions of Σ_{II} . Consequently $\Psi_F \subseteq (L - K)$, i.e., all the faulty sequences are considered as violation of the specification language *K*. The set of faulty states is defined as $S_F : \bigcup_{j=1}^r (S_{F_j})$ where S_{Fj} is the set of

states reached by the occurrence of a fault of F_j . Let H_{Fj} denote the set of all state output vectors of the faulty states belonging to S_{Fj} . Then the output partition H_{Fj} can be defined as:

$$\forall q' \in S_{Fj}, h' = h(q') \Longrightarrow h' \in H_{Fj}.$$

The set of fault labels $\Lambda_F = \{F_1, F_2, ..., F_r\}$ indicates the occurrence of a fault belonging to one of the fault partitions Σ_{II} . By adding the normal label N, we can obtain the set Λ of all the labels used by the diagnoser. We define the label function $l: Q \to \Delta$ to indicate the functional status of the system when it reaches a state $q \in Q$. Δ is the set of all possible subsets of the diagnoser labels:

$$\Delta = \begin{cases} \{N\}, \{F_1\}, \{F_2\}, \dots, \{F_r\}, \{F_1, F_2\}, \{F_1, F_2, \dots, F_r\}, \\ \{N, F_1\}, \dots, \{N, F_r\}, \{N, F_1, F_2\}, \dots, \{N, F_1, \dots, F_r\} \end{cases} .$$

Similarly, we can define Δ_F as the set of all the subsets of fault labels.

2.3.2 Events Timing Delays Modelling

The majority of sensors and actuators in manufacturing systems produce constrained events since state's changes are usually effected by a predictable flow of materials (Pandalai, 2000). Therefore, we define a set of expected consequents EC_{β} for each controllable event, $\beta \in \Sigma_c$, in order to predict uncontrollable but observable consequent events within pre-defined time periods. This EC_{β} describes the next events that should occur and the relative time periods in which they are expected.

These pre-defined time periods are determined by experts according to the system dynamic and to the desired behavior. If $u = \beta \alpha_1 \alpha_2 \dots \alpha_k$ is an observable event sequence starting by a controllable event β , and ending by the observable event sequence $\alpha_1 \alpha_2 ... \alpha_k \subset \Sigma_{uo}^*$, then the set of expected consequents $EC_{\beta}(u)$ is created when the event β occurs. $EC_{\beta}(u)$ has the following form: $EC_{\beta}(u) = \{C_{\alpha}^{\beta}, C_{\alpha}^{\beta}, ..., C_{\alpha}^{\beta}, ..., C_{\alpha}^{\beta}\}$. C_{α}^{β} is a consequent expected after the enablement of the controllable event β and it is defined as follows: $C_{\alpha i}^{\beta} = \{ \alpha_{j}, \alpha_{i}, (q_{\alpha i}, [t_{\min}^{\alpha i}, t_{\max}^{\alpha i}], J_{q\alpha i}^{\alpha i}) \}$. It means that when α_{j} occurs, the event α_i should happen at the state q_{α_i} and within the interval $[t_{\min}^{\alpha_i}, t_{\max}^{\alpha_i}]$. If it is the case then the expected consequent is satisfied. If the event α_i has occurred before $t_{\min}^{\alpha_i}$ or after $t_{\max}^{\alpha_i}$ then the expected consequent is not satisfied and it provides the fault label $l_{q_{\min}}^{\alpha_i} \in \Delta_F$, as the cause of this non-satisfaction. This set of expected has a provide the function of the expected by a function. consequent $EC_{\beta}(u)$ is evaluated by a function $EF_{\beta}(u)$. $EF_{\beta}(u)$ is equal to 1 if one of its expected consequents is not satisfied while it is equal to zero if all its expected consequents are satisfied.

2.3.3 Codiagnosability Notion Formulation

If a system composed of *n* local diagnosers with a global closed prefixed language *L*, a global closed prefixed specification language *K*, a global projection function *P*, and a predefined set of fault partitions, $\Sigma_{II} = \{\Pi_{Fl}, \Pi_{F2}, ..., \Pi_{Fr}\}$, is diagnosable using a central diagnoser. Then this system is *F*-codiagnosable according to the projection functions, $P^i : i = 1 ... n$, if and only if :

$$\exists k \in IN, \forall f \in \Pi_{F_j}, j \in \{1, 2, ..., r\}, \forall st \in (L-K) \cap \Psi_{F_j}, \\ \exists i \in \{1, 2, ..., n\}, |t| \ge k, \forall u \in P^{i^{-1}}P^i(st) \cap (L-K) \\ \Rightarrow u \in (L-K) \cap \Psi_{F_j}$$

$$\forall q \in Q, q' = \delta^i(u, q), h' = h(q') \Rightarrow h' \in H_{F_j} \\ \exists z \in \{1, 2, ..., m\} \Rightarrow EF_z(P^i(st)) = 1 \text{ and } l_z = \{F_j\}$$
(4)

The satisfaction of (4) means that the occurrence of a fault of the type F_j is diagnosable by at least one local diagnoser D^i , using the event-based, statebased or timed local models. Indeed if the faulty event sequence *s*, ending by a fault of the type F_j , is distinguishable by the central diagnoser D after the execution of k = |t| transitions, where t is a continuation of s. If u is any other event sequence belonging to (L - K) and producing the same observable event sequence as st, $P^{i}(u) = P^{i}(st)$, according to the local diagnoser D^{i} . Then the system is *F*-codiagnosable if and only if:

- *u* contains in it a fault of the type F_{j} , (event-based model),
- *u* transits D^i to a state characterized by an output vector belonging to the output partition H_{Fj} , (state-based model),
- There is at least one expected consequent, defining a temporal constraint between the occurrence of the observable events $P^i(st)$ by the diagnoser D^i , not satisfied. This expected consequent is evaluated by an expected function which provides a fault label $l = \{F_j\}$ as the cause of this non-satisfaction, (timed-model).

2.3.4 Codiagnosability Checking

The set of local diagnosers are able to diagnose any fault belonging to one of the fault partitions of F and within a finite delay, if:

$$\forall \rho \in L, \rho \in K, \forall i \in \{1, 2, ..., n\}, \exists q \in Q \Longrightarrow en_{\rho}^{i}(q) = 1 \quad (5)$$

$$\forall \rho \in L, \rho \in L-K, \forall j \in \{1, 2, ..., r\}, \rho \cap \psi_{F_{j}} \neq \phi, \exists i \in \{1, 2, ..., n\},$$

$$\exists q \in Q \Longrightarrow (en_{\rho}^{i}(q) = 0 \text{ or } EF_{q}(P^{i}(\rho)) = 1) \text{ and } l_{q} = \{F_{j}\}$$

$$|\rho| \leq k \in N$$

$$(7)$$

(5) means that all the enablement conditions of all the local diagnosers must be satisfied for any event of a sequence belonging to the global desired behavior. Thus this condition ensures that no conflict can occur between local diagnosers for the enablement of events at any state of the desired behavior. The satisfaction of (6) ensures that any event sequence violating the global desired behavior, due to the occurrence of a fault of the type F_i , must be diagnosed by at least one local diagnoser D^i when it reaches the state q. This detection and isolation are based on the non-satisfaction either of the enablement condition of the latest event in the event sequence ρ or of its expected function. In the both cases, this non-satisfaction should provide the fault label F_i . Finally (7) guarantees that this diagnosis decision will be realized in a finite delay equal to the cardinality of the event sequence ρ .

3 ILLUSTRATION EXAMPLE

3.1 Example Presentation

We monitor a wagon with an electric actuator with two senses of movement: right and left, obtained by two commands, R for the movement right and L for the movement left. Three sensors a, b and c are used to indicate the wagon location in, respectively, A, Bor C, as it is illustrated in Figure 1. We have chosen this simple example for easy understanding. The same reasoning can be followed for the application of the approach on more complex examples.



The following hypotheses must hold:

- The wagon inertia is null,
- Actuator does not fail during operation, i.e., if it does fail, the fault is at the start of operation,
- There are no ambiguity or indecision cases between the local diagnosers.

The system is modelled with two sub models: G^1 and G^2 . Their local observable events are respectively: $\Sigma_0^{-1} = \{\uparrow R, \downarrow R, \uparrow L, \downarrow L, \uparrow a, \downarrow a, \uparrow b, \downarrow b\}$ and $\Sigma_0^{-2} = \{\uparrow R, \downarrow R, \uparrow L, \downarrow L, \uparrow b, \downarrow b, \uparrow c, \downarrow c\}$. We use five Boolean state variables *a*, *b*, *c*, *R* and *L* to describe the overall wagon behavior *G*. *a*, *b* and *c* are true when the wagon is located respectively in *A*, *B* or *C*.

Each local model consists of two components: the wagon motor behavior and the change of the wagon location measured by the sensors *a* and *b* for G^1 , and *b* and *c* for G^2 . The set of fault partitions to be diagnosed is $F = \{F_1, F_2, F_3, F_4\}$. F_1, F_2, F_3 and F_4 indicate, respectively, sensor *a*, sensor *b*, sensor *c* and wagon motor stuck-on or stuck-off.

3.2 Constrained System Models

The constrained-system model *S* for the wagon example is depicted in Figure 2 and is provided by the user. S^1 and S^2 represent the local desired behaviors for the two sub models G^1 and G^2 according to their set of local observable events.

In BDES modelling, this desired behavior can be described using two tables; the first one explains the enablement conditions for the occurrence of each event and the second one is the displacement matrix for the estimation of the state output vector of each next state. These tables are shown respectively in Table 1, Table 2 and Table 3 for S^1 and S^2 .



Figure 2: Global constrained-system model S.

	Table 1:	The enablement	conditions	for S ¹	and S^2 .
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σ : S^1	en_{σ}	σ : S^2	en_{σ}
$\uparrow a$	$\overline{a.b.R.L}$	$\uparrow b$	bc.RL+bc.RL
$\downarrow a$	$a.\overline{b}.R.\overline{L}$	$\downarrow b$	b.c.R.L + b.c.R.L
$\uparrow b$	ab.RL+ab.RL	$\uparrow c$	$\overline{b.c.R.L}$
$\downarrow b$	ab.R.L+ab.R.L	$\downarrow c$	$\overline{b.c.R.L}$
$\uparrow R$	a.b.R.L	$\uparrow R$	$\overline{b.c.R.L}$
$\downarrow R$	$\overline{a}.\overline{b}.R.\overline{L}$	$\downarrow R$	$\overline{b}.c.R.\overline{L}$
$\uparrow L$	$\overline{a}.\overline{b}.\overline{R}.\overline{L} + \overline{a}.\overline{b}.\overline{R}.\overline{L}$	$\uparrow L$	$\overline{b}.c.\overline{R}.\overline{L} + b.\overline{c}.\overline{R}.\overline{L}$
$\downarrow L$	$\overline{a}.\overline{b}.\overline{R}.L + a\overline{b}.\overline{R}.L$	$\downarrow L$	b.c.R.L+b.c.R.L

Table 2:	The d	isplacement	matrix	E^1	for <i>i</i>	S	
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State variable	$\uparrow a$	$\downarrow a$	$\uparrow b$	$\downarrow b$	↑R	$\downarrow R$	$\uparrow L$	$\downarrow L$
а	1	1	0	0	0	0	0	0
b	0	0	1	1	0	0	0	0
R	0	0	0	0	1	1	0	0
L	0	0	0	0	0	0	1	1

State variable	$\uparrow b$	$\downarrow b$	$\uparrow c$	$\downarrow c$	↑R	$\downarrow R$	$\uparrow L$	$\downarrow L$
b	1	1	0	0	0	0	0	0
С	0	0	1	1	0	0	0	0
R	0	0	0	0	1	1	0	0
I	0	0	0	0	0	0	1	1

Table 3: The displacement matrix E^2 for S^2 .

3.3 Expected Consequents Definition

Two expected consequents are defined for *G*, one for each command enablement: $EC_{\uparrow R}$, $EC_{\uparrow L}$. The enablement of *R*, entails the events $\downarrow a, \uparrow b, \downarrow b$, and $\uparrow c$ to occur respectively at the states q_2, q_3, q_4 , and q_5 . $\downarrow a$ is expected to occur within the time period [1,2], after the enablement of *R*, $\uparrow b$ within the time period [3,5] after the occurrence of $\downarrow a, \downarrow b$ inside the interval [1,2], and $\uparrow c$ inside [3,5] according to the system dynamic. If $\downarrow a$ does not occur at q_2 then the wagon motor has not responded. Thus the nonsatisfaction of the corresponding expected consequent at this state indicates the occurrence of a fault belonging to Π_{F4} . If $\downarrow a$ has occurred, then *S* will transit to the state q_3 . If $\uparrow b$ has not occurred, then the non-satisfaction of the corresponding expected consequent provides the label $l = \{F_2\}$ to indicate that the sensor *b* is faulty, stuck-off, since the wagon has responded. Similarly the non occurrence of $\downarrow b$ at q_4 indicates that the sensor *b* is stuck-on. Consequently EC_{\uparrow_R} can be written:

$$EC_{\uparrow R} = \begin{cases} \{\uparrow R, \downarrow a, (q_2, [1,2], F_4)\}, \{\downarrow a, \uparrow b, (q_3, [3,5], F_2)\}, \\ \{\uparrow b, \downarrow b, (q_4, [1,2], F_2)\}, \{\downarrow b, \uparrow c, (q_5, [3,5], F_3)\} \end{cases}$$

Similarly the expected consequent for the enablement of the command *L* can be written:

$$EC_{\uparrow L} = \begin{cases} \{\uparrow L, \downarrow c, (q_8, [1,2], F_4)\}, \{\uparrow L, \downarrow b, (q_{12}, [1,2], F_4)\}, \\ \{\downarrow b, \uparrow a, (q_{13}, [3,5], F_1\}, \{\downarrow c, \uparrow b, (q_9, [3,5], F_2)\} \end{cases}.$$

3.4 Local Diagnosers Construction

Two local diagnosers D^1 and D^2 are constructed for the sub models S^1 and S^2 . Each local diagnoser contains, besides the states of the local desired behavior model, all the faulty states that can be reached by the occurrence of a fault belonging to one of the fault partitions. Each one of these faulty states is reached due to the non-satisfaction either of the enablement condition of an event or of an expected consequent. This makes the diagnoser declaring a fault. The diagnosers D^1 and D^2 are depicted respectively in Figure 3 and Figure 4. Each diagnoser state is determined by testing whether the enablement condition, or the expected consequent, is satisfied (the next state is a desire one) or not (the next state is faulty). The fault labels are calculated by determining the reason of the non-satisfaction.

The diagnoser can be initiated at any state distinguished by its output vector, i.e., the states with the dotted entrant arrows. If the diagnoser is initiated at any state distinguished by an event, the diagnoser cannot diagnose a past occurrence of a fault. As an example, the faulty states reached by an unsatisfied expected consequent cannot be distinguished from the ones of the desired behavior if the diagnoser was initiated at one of these states.

The system is F-codiagnosable if it satisfies the conditions (5), (6) and (7). The condition (5) is satisfied since the two diagnosers authorize both the events observable by them: $\forall q, en_{\uparrow b}^1 \cdot en_{\uparrow b}^2 \neq 0$ and $en_{\downarrow b}^1 \cdot en_{\downarrow b}^2 \neq 0$. The condition (6) is also verified since the local diagnosers can diagnose with certainty the occurrence of a fault belonging to one of the fault partitions of Σ_{II} .

 D^1 diagnoses with certainty the faults belonging to one of Π_{F1} , Π_{F2} and Π_{F4} while D^2 diagnoses with certainty the faults belonging to one of Π_{F2} , Π_{F3} and Π_{F4} . Finally (7) holds since the delay required to diagnose a fault belonging to one of the fault partitions, in the worst case and for any one of the two diagnosers, is finite and equal to 6 events. If we consider the non-satisfaction of an expected consequent as an event then starting from any diagnoser state of the desired behavior, the longest event sequence required to decide the occurrence of a fault is maximally equal to 6. As an example, starting from the state 7 of D^1 , the detection of the occurrence of a fault belonging to one of Π_{F1} , Π_{F2} or Π_{F4} requires, respectively, 6 events (state 21), 5 events (state 20) and 5 events (state 19). Thus, the system is F-codiagnosable.



Figure 3: Local event-state-based diagnoser, D.¹



Figure 4: Local event-state-based diagnoser, D^2 .

4 CONCLUSIONS

In this paper, a decentralized diagnosis approach is proposed to diagnose manufacturing systems. This approach is based on several local diagnosers. They diagnose together faults, which violate the specification language representing the desired behavior of the monitored system.

A simulation tool based on Stateflow of Matlab[®] is constructed in order to test and validate the proposed approach on application examples. This tool is based on a library of component models to design and to test the performances of diagnosis module for different applications.

We are developing a distributed diagnosis module to perform the diagnosis of manufacturing systems. This module uses the timed-event-statebased diagnoser, proposed in this paper, as a local diagnoser in a distributed structure.

REFERENCES

- Balemi S, Hoffmann G.J., Gyugyi P, Wong-Toi H., Franklin G.F. Supervisory control of a rapid thermal multiprocessor, *IEEE Transactions on Automatic Control*, vol. 38, n°7, pp. 1040-105, 1993.
- Debouk R., Lafortune S., and Teneketzis D. Coordinated decentralized protocols for failure diagnosis of DES, *Discrete Event Dynamic Systems: Theory and Applications*, 10(1-2):33–86, 2000.
- Lin F., Diagnosability of Discrete Event Systems and its Applications, In *Discrete Event Dynamic Systems4*, Kluwer Academic Publishers, USA. 1994.
- Pandalai D., L. E. N. Holloway, Template Languages for Fault Monitoring of Timed Discrete Event Processes, In *IEEE Transactions On Automatic Control 45(5)*, 2000.
- Philippot A., Sayed Mouchaweh M., Carré-Ménétrier V., Multi-models approach for the diagnosis of Discrete Events Systems, In *IMACS'05, International* conference on Modelling, Analyse and Control of Dynamic Systems, Paris-France, 2005.
- Qiu W., Decentralized/distributed failure diagnosis and supervisory control of DES, *PhD Thesis*, the Iowa State University, USA, 2005.
- Ramadge P., Wonham W., Supervisory control of a class of discrete event processes, In SIAM J. Control Optim. 25(1), 1987.
- Sampath M., Segupta R., Lafortune S., Sinnamohideen K., Teneketzis D., Diagnosability of discrete event systems, In 11th Int. Conf. Analysis Optimization of Systems: DES, France, 1994.
- Tripakis S., Fault Diagnosis for Timed Automata, 7th International Symposium on Formal Techniques in Real Time and Fault Tolerant Systems (FTRTFT'02), Oldenburg Germany, 2002.
- Wang Y., Supervisory Control of Boolean Discrete-Event Systems, *Thesis of Master of Applied Sciences*, University of Toronto, Canada, 2000.
- Zad S. H., Kwong R. H., Wonham W. M., Fault Diagnosis in DES: Framework and model reduction, *IEEE Transactions On Automatic Control 48(7)*, 2003.